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SPECIFICATION

Device Name	:	IGBT Module
Type Name	:	6MBI100UC-120
Spec. No.	:	MS5F 5351

Fuji Electric Co.,Ltd.
Matsumoto Factory

	DATE	NAME	APPROVED	Fuji Electric Co.,Ltd.			
DRAWN	Jan.- 31-'03	Y.Kobayashi	T.Fujihira	DWG.NO.	MS5F 5351	1 / 13	
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Revised Records

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Fuji Electric Co.,Ltd.

DWG.NO.

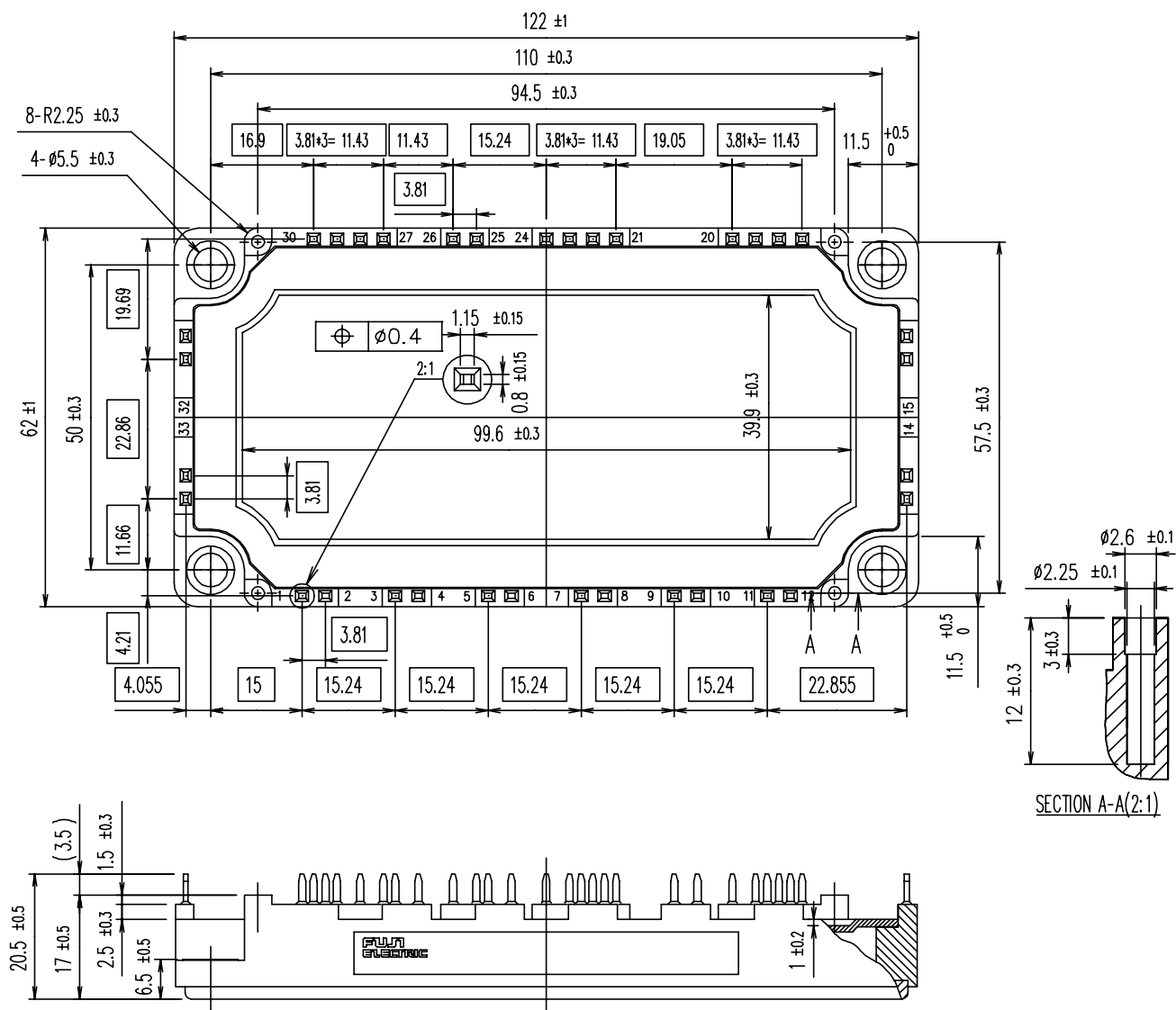
MS5F 5351

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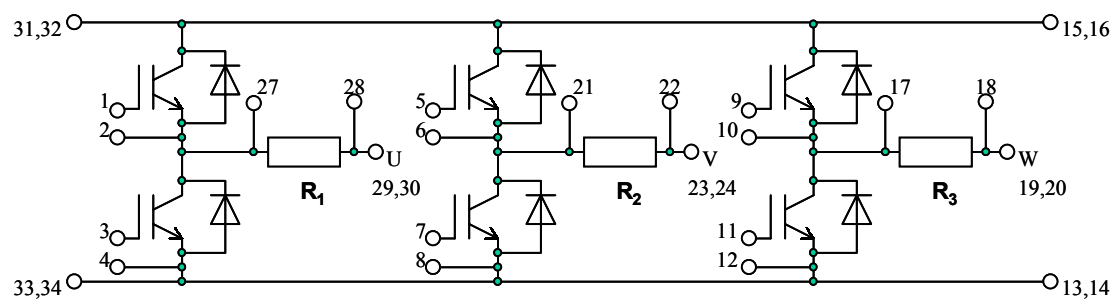
H04-004-06

6MBI100UC-120

1. Outline Drawing (Unit : mm)



2. Equivalent circuit



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3. Absolute Maximum Ratings (at Tc= 25°C unless otherwise specified)

Items		Symbols	Conditions		Maximum Ratings	Units
Collector-Emitter voltage		VCES			1200	V
Gate-Emitter voltage		VGES			±20	V
Collector current	Ic	Continuous	Tc=25°C		150	A
			Tc=80°C		100	
	Icp	1ms	Tc=25°C		300	
			Tc=80°C		200	
	-Ic				100	
		-Ic pluse			200	
Collector Power Dissipation		Pc	1 device		520	W
Junction temperature		Tj			150	°C
Storage temperature		Tstg			-40 ~ +125	
Isolation voltage	between terminal and copper base *1	Viso	AC : 1min.		2500	VAC
Screw Torque	Mounting *2	-			3.5	N・m

(*1) All terminals should be connected together when isolation test will be done.

(*2) Recommendable Value : 2.5~3.5 Nm (M5)

4. Electrical characteristics (at Tj= 25°C unless otherwise specified)

Items	Symbols	Conditions	Characteristics			Units
			min.	typ.	max.	
Zero gate voltage Collector current	ICES	VGE = 0V VCE = 1200V	-	-	1.0	mA
Gate-Emitter leakage current	IGES	VCE = 0V VGE=±20V	-	-	200	nA
Gate-Emitter threshold voltage	VGE(th)	VCE = 20V Ic = 100mA	4.5	6.5	8.5	V
Collector-Emitter saturation voltage	VCE(sat) (chip)	VGE=15V Ic = 100A	Tj= 25°C	1.75	2.1	V
			Tj=125°C	2.00	-	
Input capacitance	Cies	VCE=10V,VGE=0V,f=1MHz	-	13	-	nF
Turn-on time	ton	Vcc = 600V Ic = 100A VGE=±15V Rg = 5.6 Ω	-	0.36	1.20	μs
	tr		-	0.21	0.60	
	tr (i)		-	0.03	-	
Turn-off time	toff		-	0.37	1.00	
	tf		-	0.07	0.30	
Forward on voltage	VF (chip)	VGE=0V IF = 100A	Tj= 25°C	2.05	2.55	V
			Tj=125°C	2.00	-	
Reverse recovery time	trr	IF = 100A	-	-	0.35	μs
Lead resistance, terminal-chip	R lead	Without shunt resistance	-	5.7	-	mΩ
Shunt resistance	R shunt	Resistance of R1,R2,R3 *	-	1.5	-	mΩ

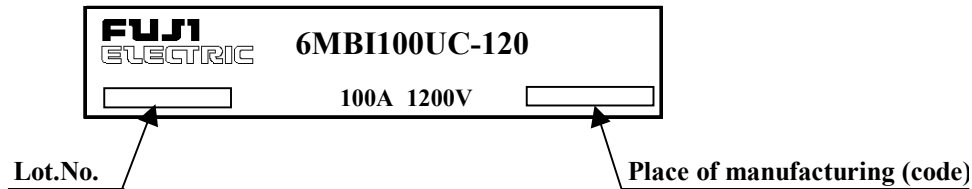
(*) R1,R2,R3 is shown in equivalent circuit(P3/13)

5. Thermal resistance characteristics

Items	Symbols	Conditions	Characteristics			Units
			min.	typ.	max.	
Thermal resistance(1device)	Rth(j-c)	IGBT	-	-	0.24	°C/W
		FWD	-	-	0.39	
Contact Thermal resistance	Rth(c-f)	with Thermal Compound (※)	-	0.05	-	

※ This is the value which is defined mounting on the additional cooling fin with thermal compound.

6. Indication on module



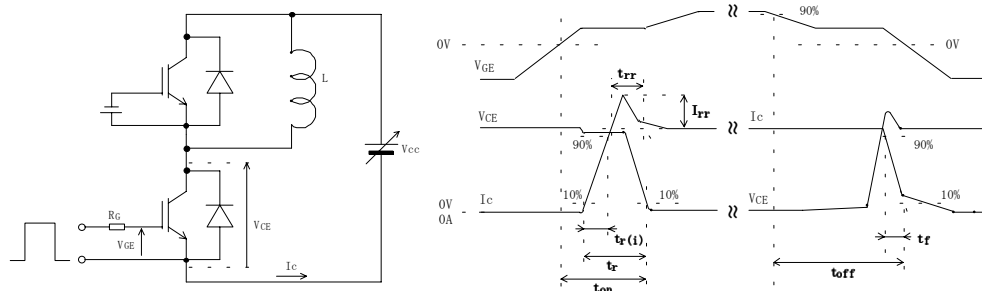
7. Applicable category

This specification is applied to IGBT Module named 6MBI100UC-120 .

8. Storage and transportation notes

- The module should be stored at a standard temperature of 5 to 35°C and humidity of 45 to 75% .
- Store modules in a place with few temperature changes in order to avoid condensation on the module surface.
- Avoid exposure to corrosive gases and dust.
- Avoid excessive external force on the module.
- Store modules with unprocessed terminals.
- Do not drop or otherwise shock the modules when transporting.

9. Definitions of switching time



10. Packing and Labeling

Display on the packing box

- Logo of production
- Type name
- Lot No
- Products quantity in a packing box

11. Reliability test results

Reliability Test Items

Test categories	Test items	Test methods and conditions	Reference norms EIAJ ED-4701	Number of sample	Acceptance number
Mechanical Tests	1 Terminal Strength (Pull test)	Pull force : 20N Test time : 10±1 sec.	A - 111 Method 1	5	(1 : 0)
	2 Mounting Strength	Screw torque : 2.5 ~ 3.5 N·m (M5) Test time : 10±1 sec.	A - 112 Method 2	5	(1 : 0)
	3 Vibration	Range of frequency : 10 ~ 500Hz Sweeping time : 15 min. Acceleration : 10G Sweeping direction : Each X,Y,Z axis Test time : 6 hr. (2hr./direction)	A - 121	5	(1 : 0)
	4 Shock	Maximum acceleration : 1000G Pulse width : 0.5msec. Direction : Each X,Y,Z axis Test time : 3 times/direction	A - 122	5	(1 : 0)
	5 Solderability	Solder temp. : 235±5 °C Immersion time : 5±1sec. Test time : 1 time Each terminal should be Immersed in solder within 1~1.5mm from the body.	A - 131	5	(1 : 0)
	6 Resistance to Soldering Heat	Solder temp. : 260±5 °C Immersion time : 10±1sec. Test time : 1 time Each terminal should be Immersed in solder within 1~1.5mm from the body.	A - 132	5	(1 : 0)
Environment Tests	1 High Temperature Storage	Storage temp. : 125±5 °C Test duration : 1000hr.	B - 111	5	(1 : 0)
	2 Low Temperature Storage	Storage temp. : -40±5 °C Test duration : 1000hr.	B - 112	5	(1 : 0)
	3 Temperature Humidity Storage	Storage temp. : 85±3 °C Relative humidity : 85±5% Test duration : 1000hr.	B - 121	5	(1 : 0)
	4 Unsaturated Pressure Cooker	Test temp. : 121 °C Atmospheric pressure : 2.03×10 ⁵ Pa (Reference value) Test duration : 20hr.	B - 123	5	(1 : 0)
	5 Temperature Cycle	Test temp. : $\begin{cases} \text{Low temp. } -40^{+3}_{-5} \text{ °C} \\ \text{High temp. } 125^{+5}_{-5} \text{ °C} \\ \text{RT } 5 \sim 35 \text{ °C} \end{cases}$ Dwell time : High ~ RT ~ Low ~ RT 1hr. 0.5hr. 1hr. 0.5hr. Number of cycles : 100 cycles	B - 131	5	(1 : 0)
	6 Thermal Shock	Test temp. : $\begin{cases} \text{High temp. } 100^{+0}_{-5} \text{ °C} \\ \text{Low temp. } 0^{+5}_{-0} \text{ °C} \end{cases}$ Used liquid : Water with ice and boiling water Dipping time : 5 min. per each temp. Transfer time : 10 sec. Number of cycles : 10 cycles	B - 141	5	(1 : 0)

Reliability Test Items

Test categories	Test items	Test methods and conditions	Reference norms EIAJ ED-4701	Number of sample	Acceptance number
Endurance Tests	1 High temperature Reverse Bias	Test temp. : $T_a = 125^{+0}_{-5}^{\circ}\text{C}$ ($T_j \leq 150^{\circ}\text{C}$) Bias Voltage : $V_C = 0.8 \times V_{CES}$ Bias Method : Applied DC voltage to C-E $V_{GE} = 0\text{V}$ Test duration : 1000hr.	D - 313	5	(1 : 0)
	2 High temperature Bias	Test temp. : $T_a = 125^{+0}_{-5}^{\circ}\text{C}$ ($T_j \leq 150^{\circ}\text{C}$) Bias Voltage : $V_C = V_{GE} = +20\text{V}$ or -20V Bias Method : Applied DC voltage to G-E $V_{CE} = 0\text{V}$ Test duration : 1000hr.	D - 323	5	(1 : 0)
	3 Temperature Humidity Bias	Test temp. : $85 \pm 3^{\circ}\text{C}$ Relative humidity : $85 \pm 5\%$ Bias Voltage : $V_C = 0.8 \times V_{CES}$ Bias Method : Applied DC voltage to C-E $V_{GE} = 0\text{V}$ Test duration : 1000hr.	B - 121	5	(1 : 0)
	4 Intermitted Operating Life (Power cycle) (for IGBT)	ON time : 2 sec. OFF time : 18 sec. Test temp. : $\Delta T_j = 100 \pm 5^{\circ}\text{deg}$ $T_j \leq 150^{\circ}\text{C}$, $T_a = 25 \pm 5^{\circ}\text{C}$ Number of cycles : 15000 cycles	D - 322	5	(1 : 0)

Failure Criteria

Item	Characteristic	Symbol	Failure criteria		Unit	Note
			Lower limit	Upper limit		
Electrical characteristic	Leakage current	ICES	-	USL×2	mA	
		±IGES	-	USL×2	μA	
	Gate threshold voltage	VGE(th)	LSL×0.8	USL×1.2	mA	
	Saturation voltage	VCE(sat)	-	USL×1.2	V	
	Forward voltage	VF	-	USL×1.2	V	
	Thermal resistance	IGBT ΔV_{GE} or ΔV_{CE}	-	USL×1.2	mV	
		FWD ΔV_F	-	USL×1.2	mV	
Visual inspection	Isolation voltage	Viso	Broken insulation		-	
	Visual inspection [Peeling Plating and the others	-	The visual sample		-	

LSL : Lower specified limit.

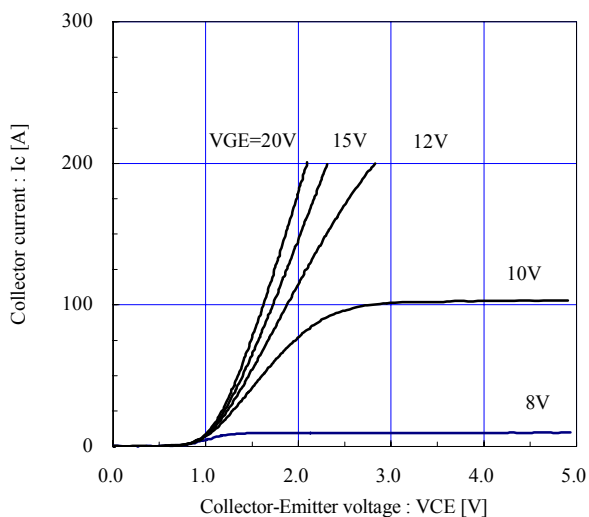
USL : Upper specified limit.

Note : Each parameter measurement read-outs shall be made after stabilizing the components at room ambient for 2 hours minimum, 24 hours maximum after removal from the tests. And in case of the wetting tests, for example, moisture resistance tests, each component shall be made wipe or dry completely before the measurement.

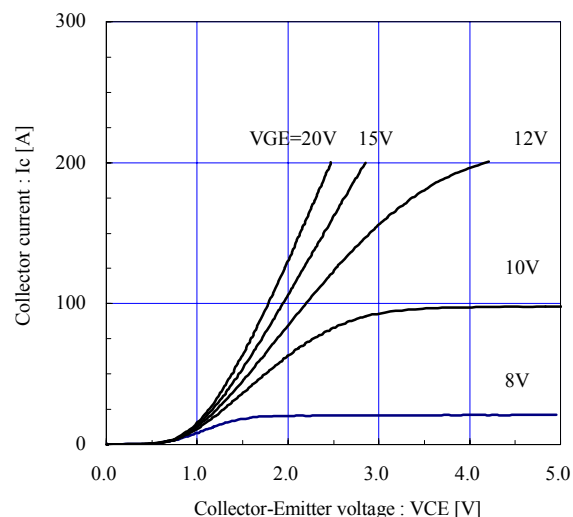
Reliability Test Results

Test categories	Test items	Reference norms EIAJ ED-4701	Number of test sample	Number of failure sample
Mechanical Tests	1 Terminal Strength (Pull test)	A - 111 Method 1	5	0
	2 Mounting Strength	A - 112 Method 2	5	0
	3 Vibration	A - 121	5	0
	4 Shock	A - 122	5	0
	5 Solderability	A - 131	5	0
	6 Resistance to Soldering Heat	A - 132	5	0
Environment Tests	1 High Temperature Storage	B - 111	5	0
	2 Low Temperature Storage	B - 112	5	0
	3 Temperature Humidity Storage	B - 121	5	0
	4 Unsaturated Pressure Cooker	B - 123	5	0
	5 Temperature Cycle	B - 131	5	0
	6 Thermal Shock	B - 141	5	0
Endurance Tests	1 High temperature Reverse Bias	D - 313	5	0
	2 High temperature Bias (for gate)	D - 323	5	0
	3 Temperature Humidity Bias	B - 121	5	0
	4 Intermitted Operating Life (Power cycling) (for IGBT)	D - 322	5	0

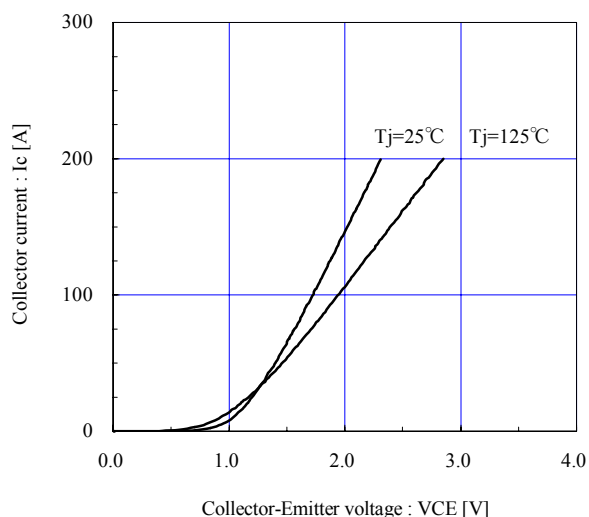
Collector current vs. Collector-Emittor voltage
Tj= 25°C / chip



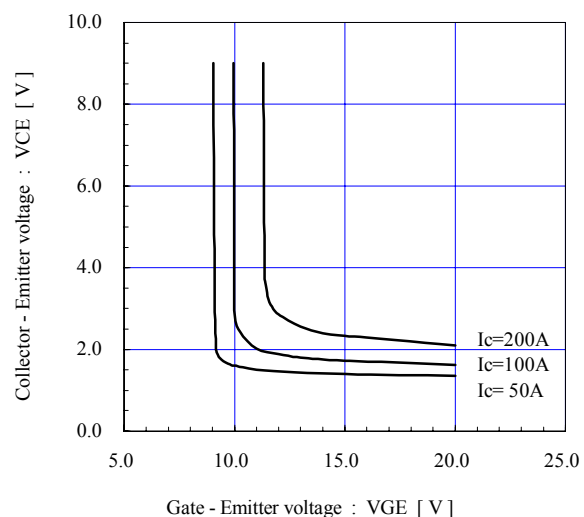
Collector current vs. Collector-Emittor voltage
Tj= 125°C / chip



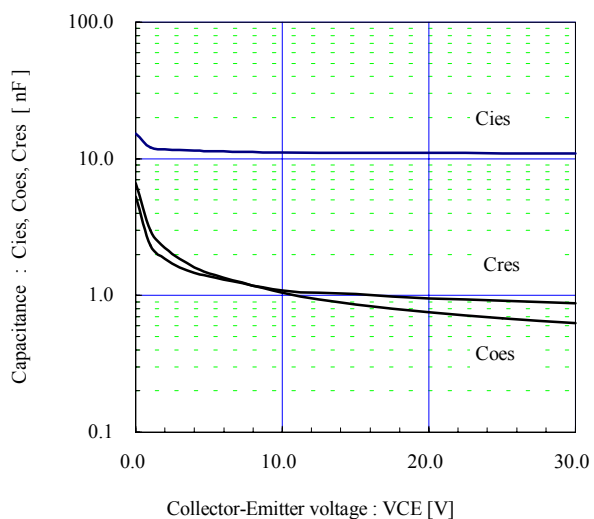
Collector current vs. Collector-Emittor voltage
VGE=15V (typ.) / chip



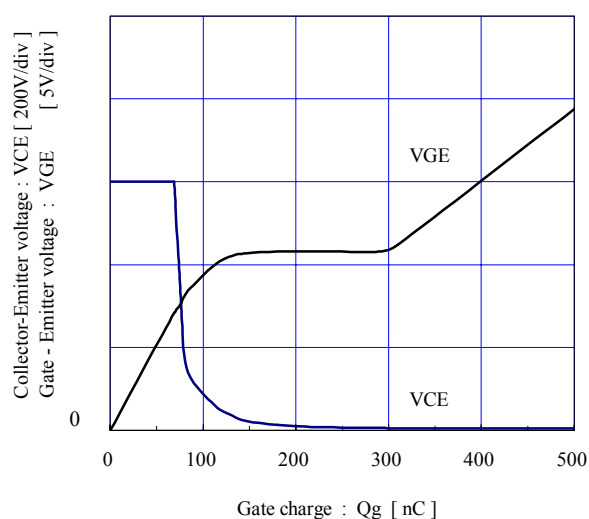
Collector-Emittor voltage vs. Gate-Emittor voltage
Tj=25°C / chip

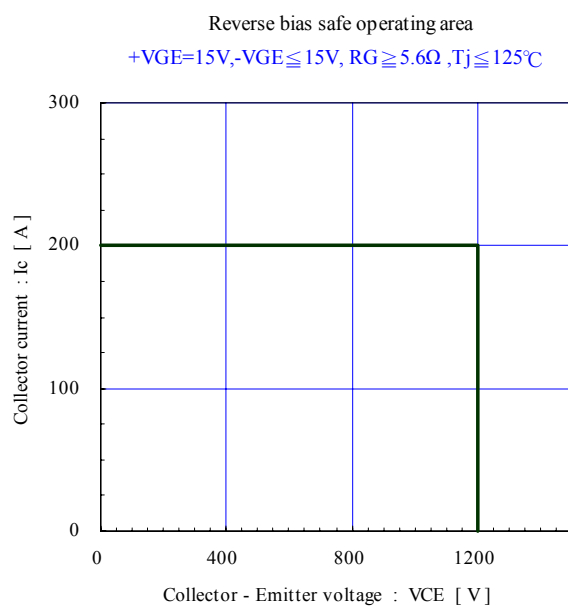
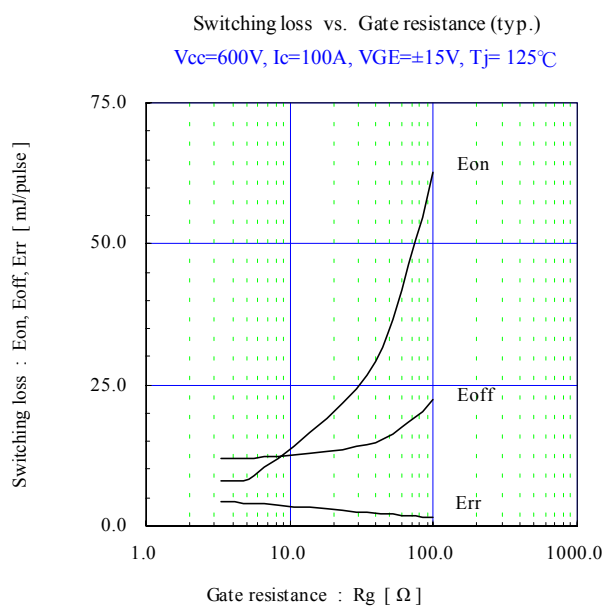
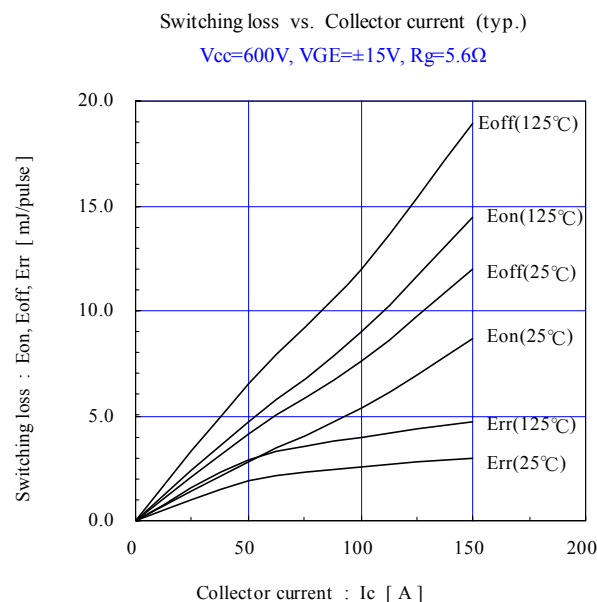
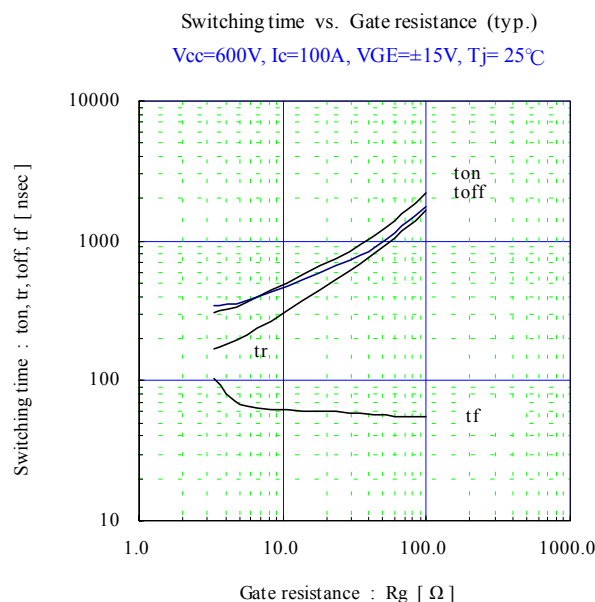
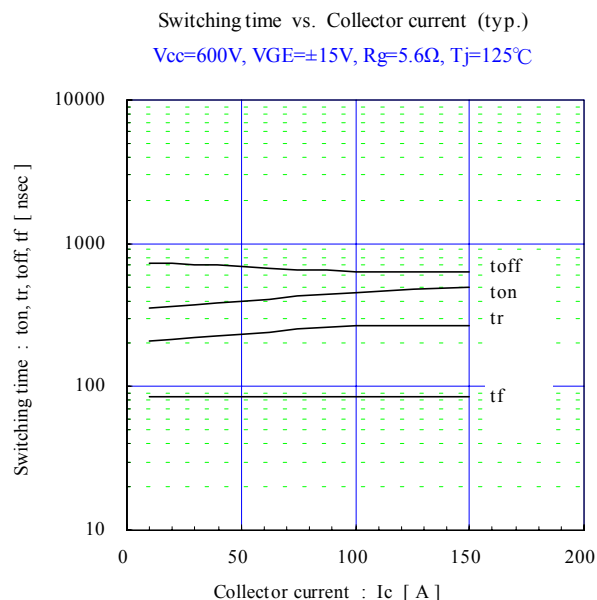
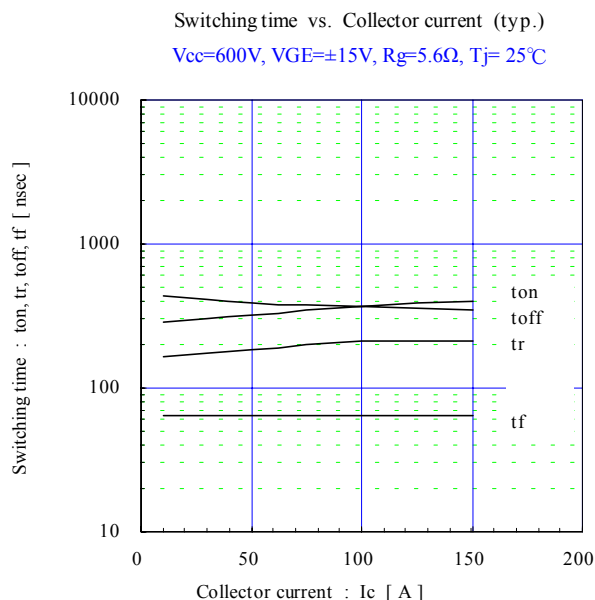


Capacitance vs. Collector-Emittor voltage (typ.)
VGE=0V, f= 1MHz, Tj= 25°C



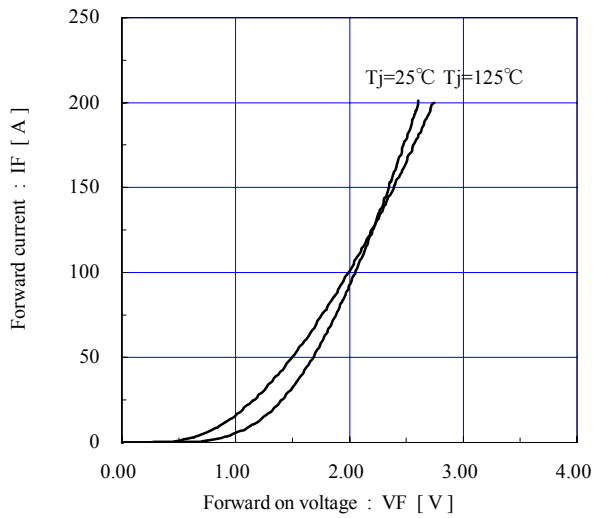
Dynamic Gate charge (typ.)
Vcc=600V, Ic=100A, Tj= 25°C



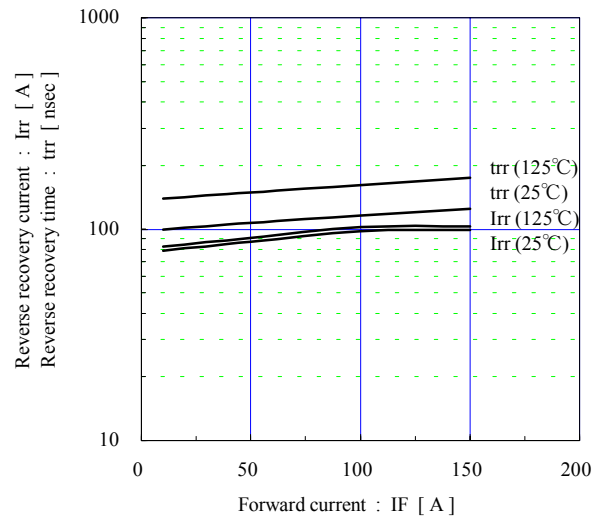


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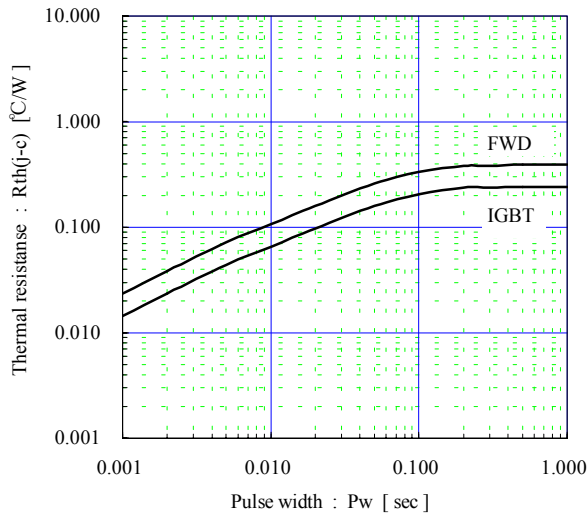
Forward current vs. Forward on voltage (typ.)
chip



Reverse recovery characteristics (typ.)
 $V_{cc}=600\text{V}$, $V_{GE}=\pm 15\text{V}$, $R_g=5.6\Omega$



Transient thermal resistance



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Warnings

- This product shall be used within its absolute maximum rating (voltage, current, and temperature).
This product may be broken in case of using beyond the ratings.
製品の絶対最大定格（電圧、電流、温度等）の範囲内で御使用下さい。
絶対最大定格を超えて使用すると、素子が破壊する場合があります。
- Connect adequate fuse or protector of circuit between three-phase line and this product to prevent the equipment from causing secondary destruction.
万一の不慮の事故で素子が破壊した場合を考慮し、商用電源と本製品の間に適切な容量のヒューズ又はブレーカーを必ず付けて2次破壊を防いでください。
- Use this product after realizing enough working on environment and considering of product's reliability life.
This product may be broken before target life of the system in case of using beyond the product's reliability life.
製品の使用環境を十分に把握し、製品の信頼性寿命が満足できるか検討の上、本製品を適用して下さい。
製品の信頼性寿命を超えて使用した場合、装置の目標寿命より前に素子が破壊する場合があります。
- If the product had been used in the environment with acid, organic matter, and corrosive gas (hydrogen sulfide, sulfurous acid gas), the product's performance and appearance can not be ensured easily.
酸・有機物・腐食性ガス（硫化水素、亜硫酸ガス等）を含む環境下で使用された場合、製品機能・外観などの保証は致しかねます。
- Use this product within the power cycle curve (Technical Rep.No. : MT5F12959)
本製品は、パワーサイクル寿命カーブ以下で使用下さい（技術資料No: MT5F12959）
- Never add mechanical stress to deform the main or control terminal.
The deformed terminal may cause poor contact problem.
主端子及び制御端子に応力を与えて変形させないで下さい。 端子の変形により、接触不良などを引き起こす場合があります。
- According to the outline drawing, select proper length of screw for main terminal.
Longer screws may break the case.
本製品に使用する主端子用のネジの長さは、外形図に従い正しく選定下さい。
ネジが長いとケースが破損する場合があります。
- Use this product with keeping the cooling fin's flatness between screw holes within 100um at 100mm and the roughness within 10um. Also keep the tightening torque within the limits of this specification.
Improper handling may cause isolation breakdown and this may lead to a critical accident.
冷却フィンにネジ取り付け位置間で平坦度を100mmで100um以下、表面の粗さは10um以下にして下さい。 誤った取り扱いをすると絶縁破壊を起こし、重大事故に発展する場合があります。
- It shall be confirmed that IGBT's operating locus of the turn-off voltage and current are within the RBSOA specification. This product may be broken if the locus is out of the RBSOA.
ターンオフ電圧・電流の動作軌跡がRBSOA仕様内にあることを確認して下さい。
RBSOAの範囲を超えて使用すると素子が破壊する可能性があります。
- If excessive static electricity is applied to the control terminals, the devices may be broken.
Implement some countermeasures against static electricity.
制御端子に過大な静電気が印加された場合、素子が破壊する場合があります。
取り扱い時は静電気対策を実施して下さい。

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